Search Notes



Application/Control No.	Applic Reexa
10/620 456	I I FF (

Examiner
Paul Contino

Applicant(s)/Patent under
Reexamination
LEE, CHIN
Art Unit
2114

SEARCHED				
Class	Subclass	Date	Examiner	
714	718	11/29/2006	PFC	
714	797	5/1/2007	PFC	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		-		
included in	search - see hterference tout	5/1/2007	PFC	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Search	11/28/2006	PFC	
EAST (all databases searched)	11/29/2006	PFC	
714/4,42,54,718,719 - text searched [see included search report]	11/28/2006	PFC	
ACM/IEEE (+test +memory/"multiple/plurality of memory" +compare [+sdram])	11/29/2006	PFC	
SEARCHED subclasses updated	4/30/2007	PFC	
714/718,719,797,27 - text searched [see included search report]	5/1/2007	PFC	
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